



Voltage Detectors, Delay Circuit Built-In

GENERAL DESCRIPTION

The XC61F series are highly accurate, low power consumption voltage detectors, manufactured using CMOS and laser trimming technologies. A delay circuit is built-in to each detector.

Detect voltage is extremely accurate with minimal temperature drift.

Both CMOS and N-channel open drain output configurations are available.

Since the delay circuit is built-in, peripherals are unnecessary and high density mounting is possible.

APPLICATIONS

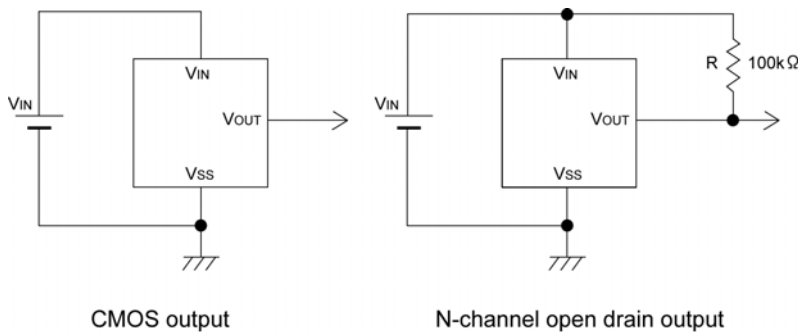
- Microprocessor reset circuitry
- Memory battery back-up circuits
- Power-on reset circuits
- Power failure detection
- System battery life and charge voltage monitors
- Delay circuitry

FEATURES

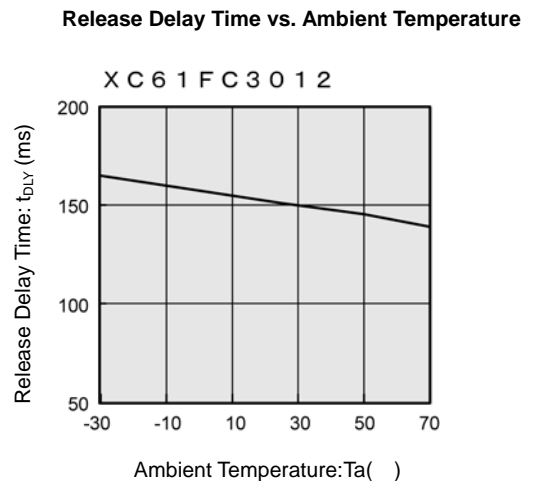
- Highly Accurate** : $\pm 2\%$
- Low Power Consumption** : $1.0 \mu A$ (TYP.) [$V_{IN}=2.0V$]
- Detect Voltage Range** : $1.6V \sim 6.0V$ in $0.1V$ increments
- Operating Voltage Range** : $0.7V \sim 10.0V$
- Detect Voltage Temperature Characteristics** : $\pm 100ppm/$ (TYP.)
- Built-In Delay Circuit** : $1ms \sim 50ms$
 $50ms \sim 200ms$
 $80ms \sim 400ms$
- Output Configuration** : N-channel open drain or CMOS
- Packages** : SOT-23
 : SOT-89
 : TO-92

* No parts are available with an accuracy of $\pm 1\%$

TYPICAL APPLICATION CIRCUITS

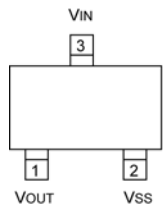


TYPICAL PERFORMANCE CHARACTERISTICS

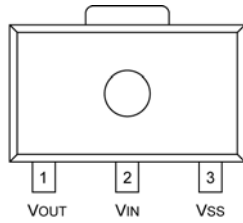




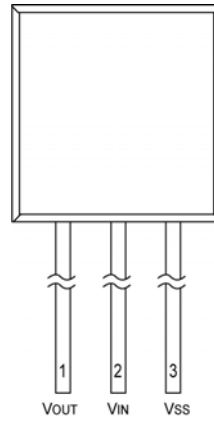
PIN CONFIGURATION



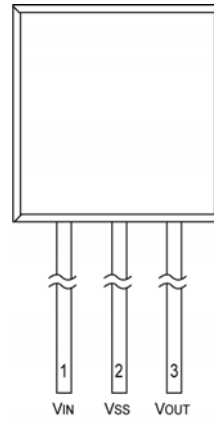
SOT-23
(TOP VIEW)



SOT-89
(TOP VIEW)



TO-92 (T Type)
(SIDE VIEW)



TO-92 (L Type)
(SIDE VIEW)

PIN ASSIGNMENT

PIN NUMBER				PIN NAME	FUNCTION
SOT-23	SOT-89	TO-92 (T)	TO-92 (L)		
3	2	2	1	VIN	Supply Voltage Input
2	3	3	2	VSS	Ground
1	1	1	3	VOUT	Output



PRODUCT CLASSIFICATION

Ordering Information

XC61F - (*)

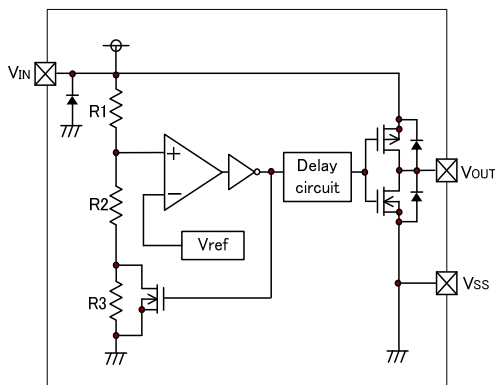
DESIGNATOR	DESCRIPTION	SYMBOL	DESCRIPTION
	Output Configuration	C	CMOS output
		N	N-ch open drain output
	Detect Voltage	16 ~ 60	e.g. 2.5V 2, 5
			e.g. 3.8V 3, 8
	Release Output Delay	1	50ms ~ 200ms
		4	80ms ~ 400ms
		5	1ms ~ 50ms
	Detect Accuracy	2	Within $\pm 2.0\%$
-	Packages Taping Type ^{(*)2}	MR	SOT-23
		MR-G	SOT-23 (Halogen & Antimony free)
		PR	SOT-89
		PR-G	SOT-89 (Halogen & Antimony free)
		TH	TO-92 (Standard): Paper type
		TB	TO-92 (Standard): Bag
		LH	TO-92 (Custom pin configuration): Paper type (Discontinued Product)
		LB	TO-92 (Custom pin configuration): Bag (Discontinued Product)

(*)1 The "-G" suffix indicates that the products are Halogen and Antimony free as well as being fully RoHS compliant.

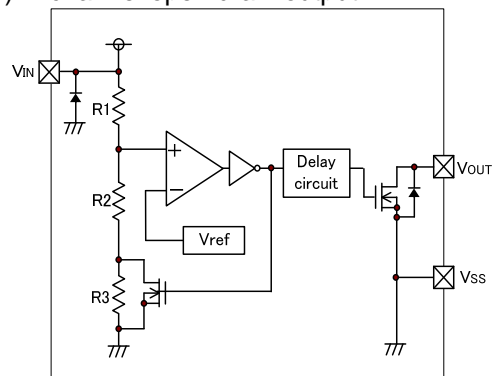
(*)2 The device orientation is fixed in its embossed tape pocket. For reverse orientation, please contact your local Torex sales office or representative. (Standard orientation: R- , Reverse orientation: L-)

BLOCK DIAGRAMS

(1) CMOS output



(2) N-channel open drain output





ABSOLUTE MAXIMUM RATINGS

Ta = 25

PARAMETER	SYMBOL	RATINGS	UNITS
Input Voltage	V _{IN}	12.0	V
Output Current	I _{OUT}	50	mA
Output Voltage	CMOS	V _{SS} -0.3 ~ V _{IN} + 0.3	V
	N-ch open drain	V _{SS} -0.3 ~ 9	
Power Dissipation	SOT-23	250	mW
	SOT-89	500	
	TO-92	300	
Operating Temperature Range	T _{opr}	-30 ~ +85	
Storage Temperature Range	T _{stg}	-40 ~ +125	

ELECTRICAL CHARACTERISTICS

Ta = 25

PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS	CIRCUIT	
Detect Voltage	V _{DF}		V _{DF(T)} x 0.98	V _{DF(T)}	V _{DF(T)} x 1.02	V		
Hysteresis Width	V _{HYS}		V _{DF} x 0.02	V _{DF} x 0.05	V _{DF} x 0.08	V		
Supply Current	I _{SS}	V _{IN} = 1.5V	-	0.9	2.6	μA		
		V _{IN} = 2.0V	-	1.0	3.0			
		V _{IN} = 3.0V	-	1.3	3.4			
		V _{IN} = 4.0V	-	1.6	3.8			
		V _{IN} = 5.0V	-	2.0	4.2			
Operating Voltage	V _{IN}	V _{DF} = 1.6V to 6.0V	0.7	-	10.0	V		
Output Current	I _{OUT}	N-ch V _{DS} = 0.5V	V _{IN} = 1.0V	1.0	2.2	-	mA	
			V _{IN} = 2.0V	3.0	7.7	-		
			V _{IN} = 3.0V	5.0	10.1	-		
			V _{IN} = 4.0V	6.0	11.5	-		
			V _{IN} = 5.0V	7.0	13.0	-		
		P-ch V _{DS} = 2.1V (CMOS Output)	V _{IN} = 8.0V	-	-10.0	-2.0		
Leak Current	CMOS Output	I _{leak}	V _{IN} = 10.0V, V _{OUT} = 10.0V	-	0.01	-	μA	
	Nch Open Drain			-	0.01	0.1		
Detect Voltage Temperature Characteristics		$\frac{V_{DF}}{T_{opr} \cdot V_{DF}}$	-	± 100	-	ppm/	-	
Release Delay Time (V _{DR} V _{OUT} inversion)		T _{DLY} *	V _{IN} changes from 0.6V to 10V	50	-	200	ms	
				80		400		
				1		50		

V_{DF} (T): Setting detect voltage value

Release Voltage: V_{DR} = V_{DF} + V_{HYS}

* Release Delay Time: 1ms to 50ms & 80ms to 400ms versions are also available.

Note: The power consumption during power-start to output being stable (release operation) is 2 μA greater than it is after that period (completion of release operation) because of delay circuit through current.



OPERATIONAL EXPLANATION

CMOS output

When a voltage higher than the release voltage (V_{DR}) is applied to the voltage input pin (V_{IN}), the voltage will gradually fall. When a voltage higher than the detect voltage (V_{DF}) is applied to V_{IN} , output (V_{OUT}) will be equal to the input at V_{IN} .

Note that high impedance exists at V_{OUT} with the N-channel open drain configuration. If the pin is pulled up, V_{OUT} will be equal to the pull up voltage.

When V_{IN} falls below V_{DF} , V_{OUT} will be equal to the ground voltage (V_{SS}) level (detect state). Note that this also applies to N-channel open drain configurations.

When V_{IN} falls to a level below that of the minimum operating voltage (V_{MIN}) output will become unstable. Because the output pin is generally pulled up with N-channel open drain configurations, output will be equal to pull up voltage.

When V_{IN} rises above the V_{SS} level (excepting levels lower than minimum operating voltage), V_{OUT} will be equal to V_{SS} until V_{IN} reaches the V_{DR} level.

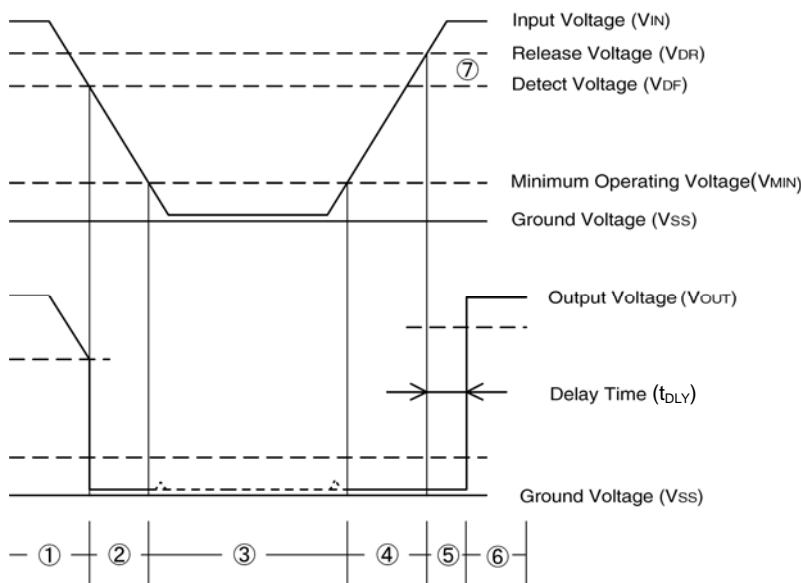
Although V_{IN} will rise to a level higher than V_{DR} , V_{OUT} maintains ground voltage level via the delay circuit.

Following transient delay time, V_{IN} will be output at V_{OUT} . Note that high impedance exists with the N-channel open drain configuration and that voltage will be dependent on pull up.

Notes:

1. The difference between V_{DR} and V_{DF} represents the hysteresis range.
2. Release delay time (t_{DLY}) represents the time it takes for V_{IN} to appear at V_{OUT} once the said voltage has exceeded the V_{DR} level.

Timing Chart





DIRECTIONS FOR USE

Notes on Use

1. Please use this IC within the stated maximum ratings. The IC is liable to malfunction should the ratings be exceeded.
2. When a resistor is connected between the V_{IN} pin and the input with CMOS output configurations, oscillation may occur as a result of voltage drops at R_{IN} if load current (I_{OUT}) exists. It is therefore recommend that no resistor be added. (refer to Oscillation Description (1) below)
3. When a resistor is connected between the V_{IN} pin and the input with CMOS output configurations, irrespective of N-ch output configurations, oscillation may occur as a result of through current at the time of voltage release even if load current (I_{OUT}) does not exist. (refer to Oscillation Description (2) below)
4. With a resistor connected between the V_{IN} pin and the input, detect and release voltage will rise as a result of the IC's supply current flowing through the V_{IN} pin.
5. If a resistor (R_{IN}) must be used, then please use with as small a level of input impedance as possible in order to control the occurrences of oscillation as described above.
Further, please ensure that R_{IN} is less than $10k$ and that C_{IN} is more than $0.1 \mu F$ (Figure 1). In such cases, detect and release voltages will rise due to voltage drops at R_{IN} brought about by the IC's supply current.
6. Depending on circuit's operation, transient delay time of this IC can be widely changed due to upper limits or lower limits of operational ambient temperature.

Oscillation Description

- (1) Oscillation as a result of output current with the CMOS output configuration:

When the voltage applied at IN rises, release operations commence and the detector's output voltage increases. Load current (I_{OUT}) will flow through R_L . Because a voltage drop ($R_{IN} \times I_{OUT}$) is produced at the R_{IN} resistor, located between the input (IN) and the V_{IN} pin, the load current will flow via the IC's V_{IN} pin. The voltage drop will also lead to a fall in the voltage level at the V_{IN} pin. When the V_{IN} pin voltage level falls below the detect voltage level, detect operations will commence. Following detect operations, load current flow will cease and since voltage drop at R_{IN} will disappear, the voltage level at the V_{IN} pin will rise and release operations will begin over again.

Oscillation may occur with this " release - detect - release " repetition.

Further, this condition will also appear via means of a similar mechanism during detect operations.

- (2) Oscillation as a result of through current:

Since the XC61F series are CMOS ICs, through current will flow when the IC's internal circuit switching operates (during release and detect operations). Consequently, oscillation is liable to occur during release voltage operations as a result of output current which is influenced by this through current (Figure 3).

Since hysteresis exists during detect operations, oscillation is unlikely to occur.

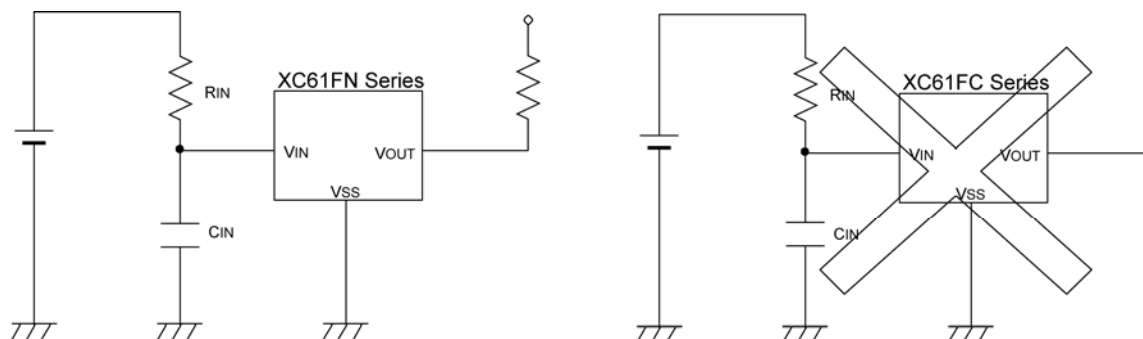


Figure 1. When using an input resistor



DIRECTIONS FOR USE (Continued)

Oscillation Description (Continued)

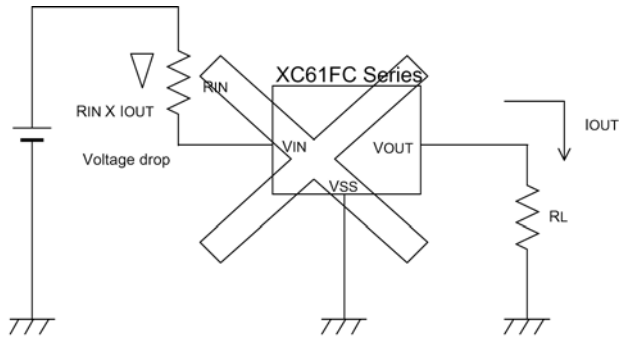


Figure 2. Oscillation in relation to output current

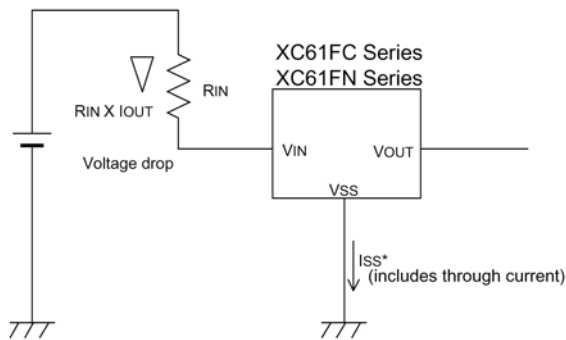
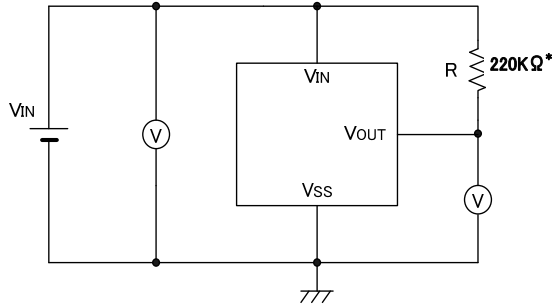


Figure 3. Oscillation in relation to through current

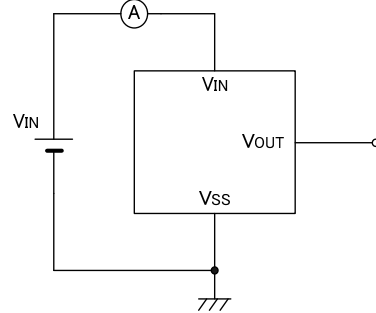


TEST CIRCUITS

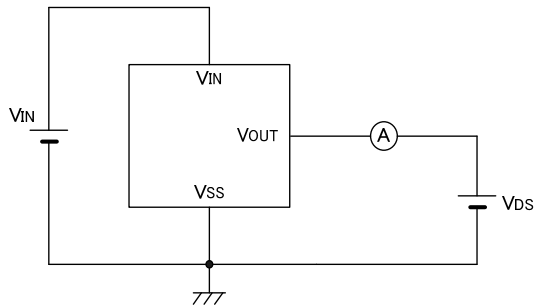
Circuit



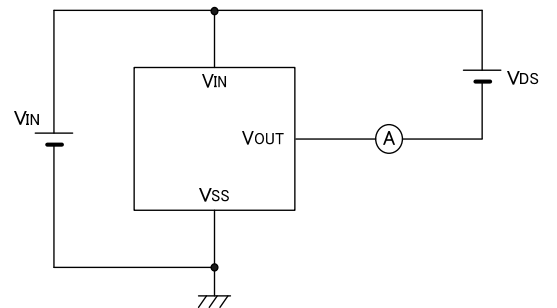
Circuit



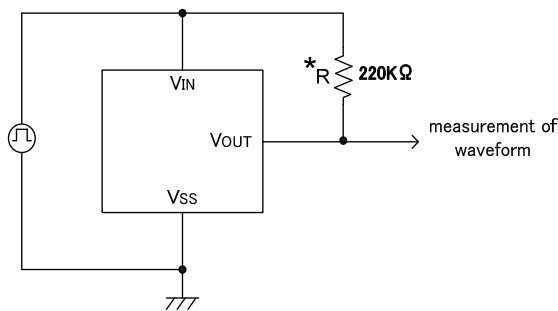
Circuit



Circuit



Circuit

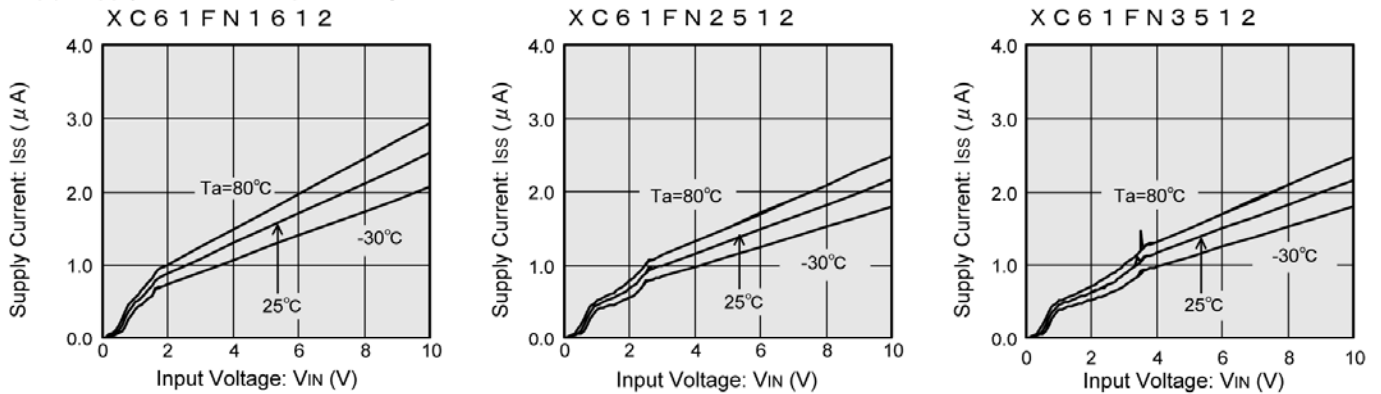


*Not necessary with CMOS output products.

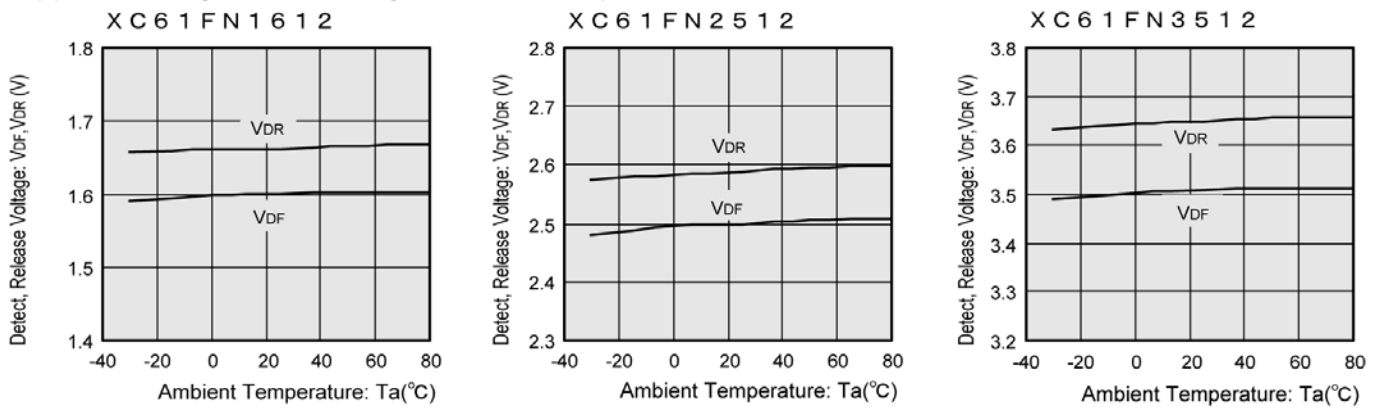


TYPICAL PERFORMANCE CHARACTERISTICS

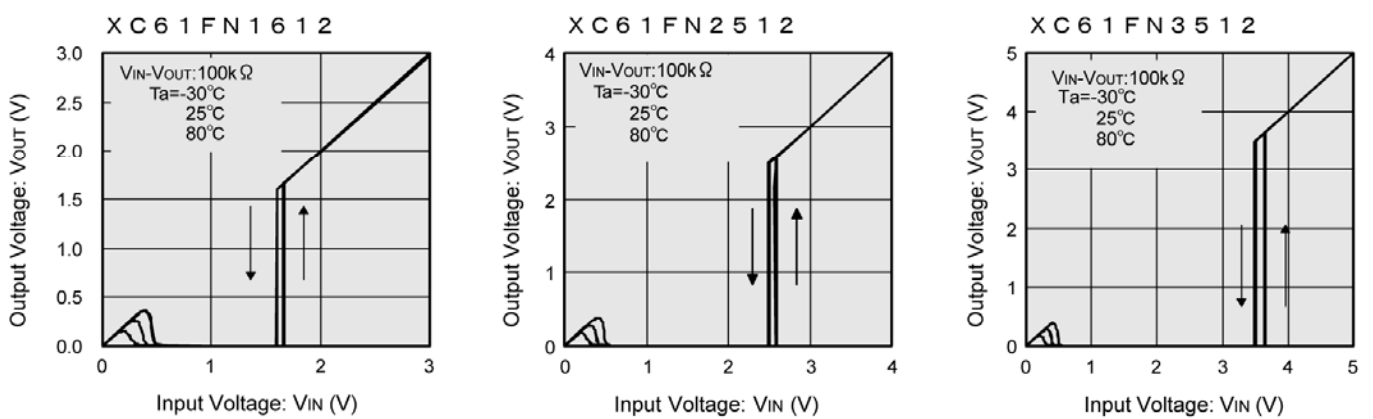
(1) Supply Current vs. Input Voltage



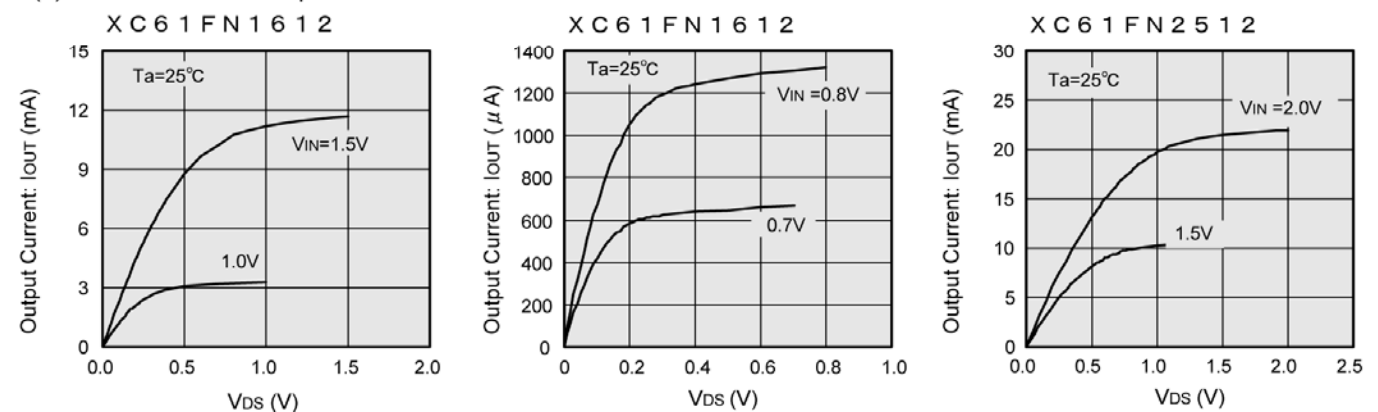
(2) Detect Voltage, Release Voltage vs. Ambient Temperature



(3) Output Voltage vs. Input Voltage



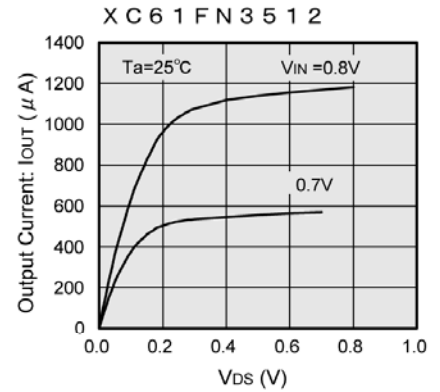
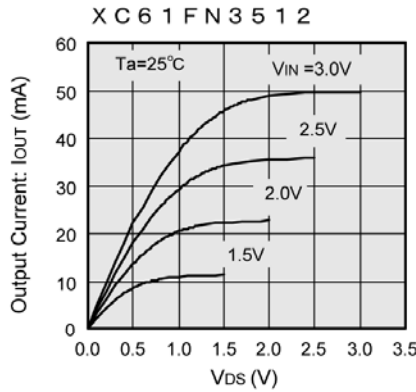
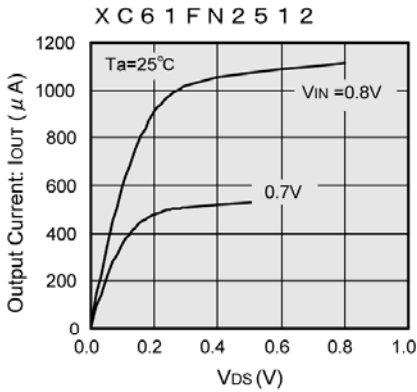
(4) N-Channel Driver Output Current vs. VDS



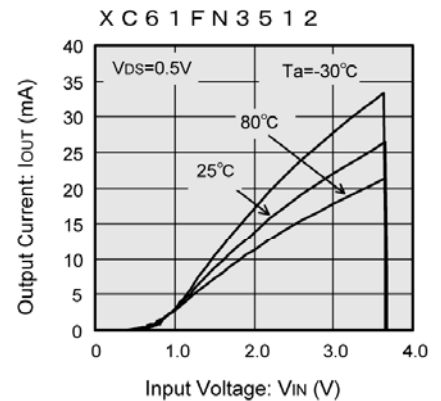
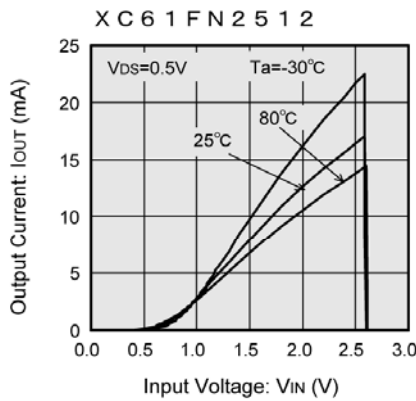
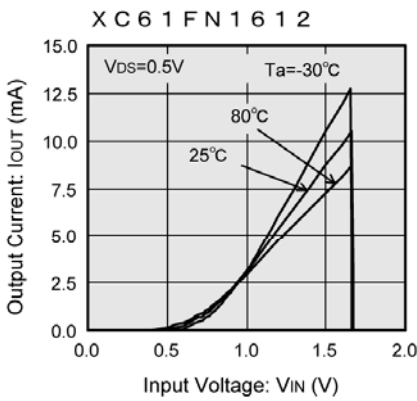


TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

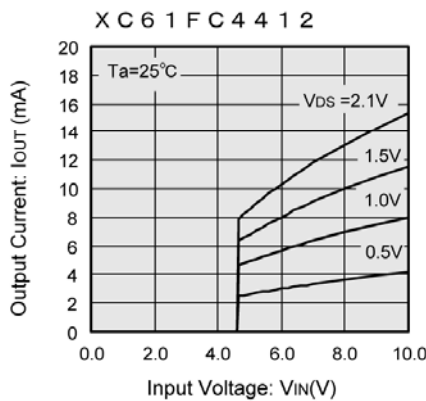
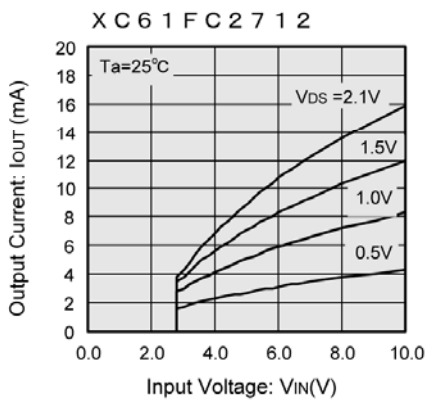
(4) N-Channel Driver Output Current vs. V_{DS} (Continued)



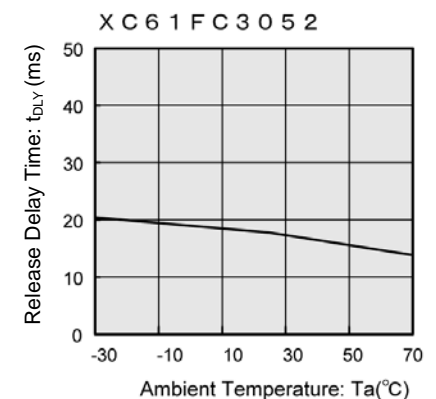
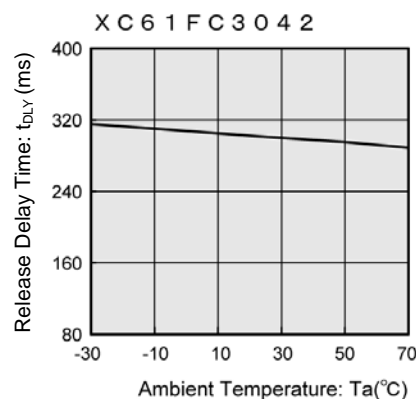
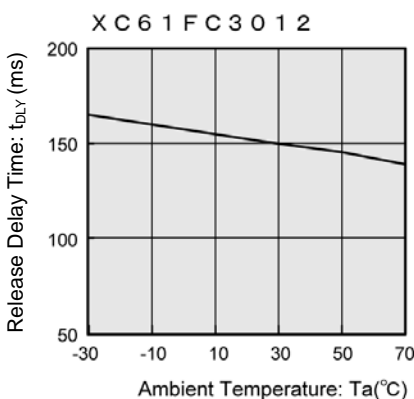
(5) N-Channel Driver Output Current vs. Input Voltage



(6) P-Channel Driver Output Current vs. Input Voltage



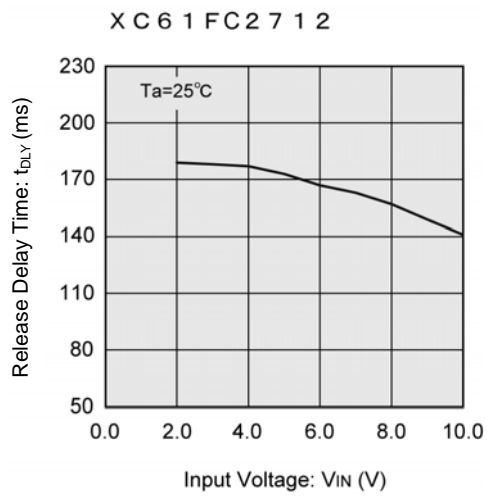
(7) Release Delay Time vs. Ambient Temperature





TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

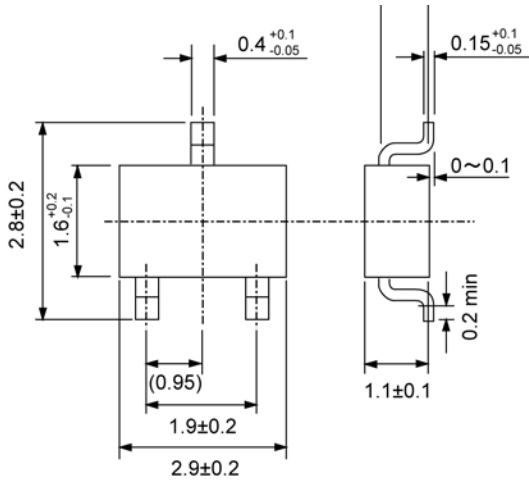
(8) Release Delay Time vs. Input Voltage



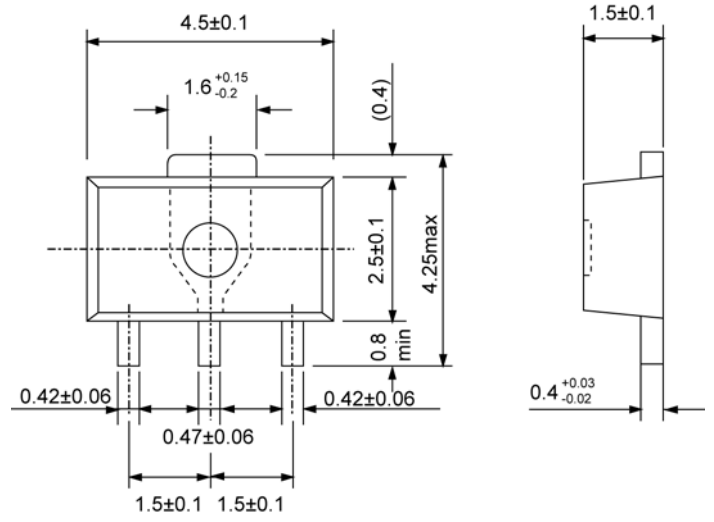


PACKAGING INFORMATION

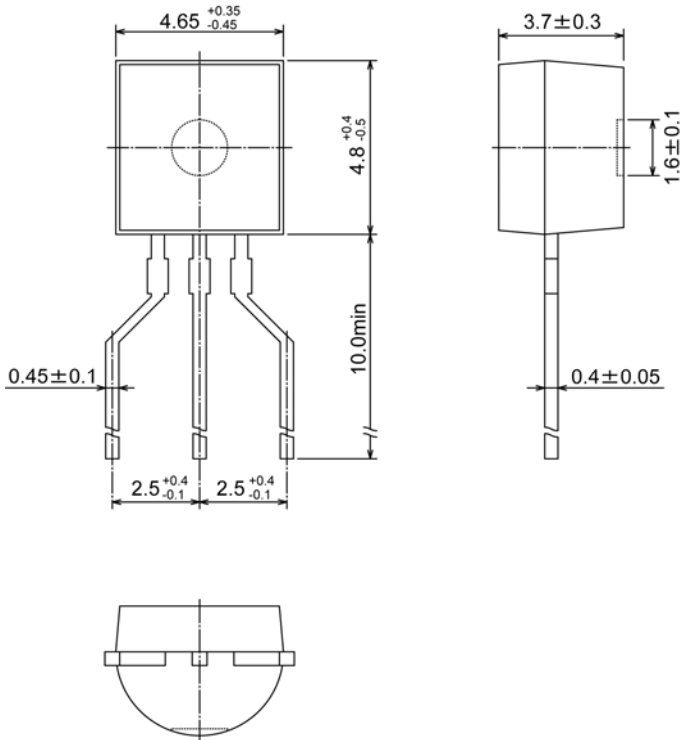
SOT-23



SOT-89



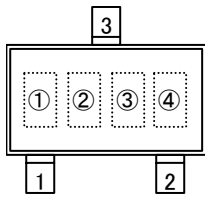
TO-92



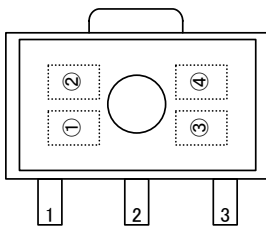


MARKING RULE

SOT-23, SOT-89



SOT-23
(TOP VIEW)



SOT-89
(TOP VIEW)

Represents integer of detect voltage and output configuration
CMOS output (XC61FC series)

MARK	CONFIGURATION	VOLTAGE (V)
A	CMOS	0.x
B	CMOS	1.x
C	CMOS	2.x
D	CMOS	3.x
E	CMOS	4.x
F	CMOS	5.x
H	CMOS	6.x

N-channel open drain (XC61FN series)

MARK	CONFIGURATION	VOLTAGE (V)
K	N-ch	0.x
L	N-ch	1.x
M	N-ch	2.x
N	N-ch	3.x
P	N-ch	4.x
R	N-ch	5.x
S	N-ch	6.x

Represents decimal number of detect voltage

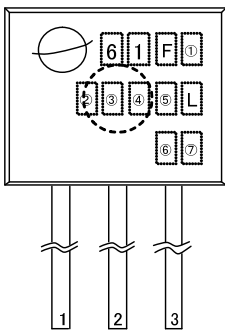
MARK	VOLTAGE (V)	MARK	VOLTAGE (V)
0	x.0	5	x.5
1	x.1	6	x.6
2	x.2	7	x.7
3	x.3	8	x.8
4	x.4	9	x.9

Represents delay time

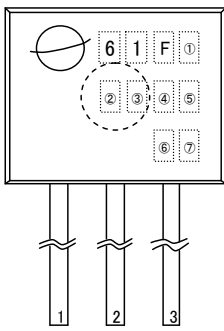
VOLTAGE (V)	DELAY TIME
5	50 ~ 200ms
6	80 ~ 400ms
7	1 ~ 50ms

Represents assembly lot number (Based on internal standards)

TO-92



TO-92 (L Type)
(TOP VIEW)



TO-92 (T Type)
(TOP VIEW)

Represents output configuration

MARK	OUTPUT CONFIGURATION
C	CMOS
N	N-ch

Represents detect voltage

MARK		VOLTAGE (V)
3	3	3.3
5	0	5.0

Represents delay time

MARK	DELAY TIME
1	50ms ~ 200ms
4	80ms ~ 400ms
5	1ms ~ 50ms

Represents detect voltage accuracy

MARK	DETECT VOLTAGE ACCURACY
2	Within $\pm 2\%$

Represents a least significant digit of the production year (ex.)

MARK	PRODUCTION YEAR
3	2003
4	2004

Represents production lot number

0 to 9, A to Z repeated (G, I, J, O, Q, W expected)



1. The products and product specifications contained herein are subject to change without notice to improve performance characteristics. Consult us, or our representatives before use, to confirm that the information in this datasheet is up to date.
2. We assume no responsibility for any infringement of patents, patent rights, or other rights arising from the use of any information and circuitry in this datasheet.
3. Please ensure suitable shipping controls (including fail-safe designs and aging protection) are in force for equipment employing products listed in this datasheet.
4. The products in this datasheet are not developed, designed, or approved for use with such equipment whose failure of malfunction can be reasonably expected to directly endanger the life of, or cause significant injury to, the user.
(e.g. Atomic energy; aerospace; transport; combustion and associated safety equipment thereof.)
5. Please use the products listed in this datasheet within the specified ranges.
Should you wish to use the products under conditions exceeding the specifications, please consult us or our representatives.
6. We assume no responsibility for damage or loss due to abnormal use.
7. All rights reserved. No part of this datasheet may be copied or reproduced without the prior permission of TOREX SEMICONDUCTOR LTD.

TOREX SEMICONDUCTOR LTD.